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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Amphenol CN (Auden)**

Certificate No: **DAE3-495\_Apr11**

## CALIBRATION CERTIFICATE

Object **DAE3 - SD 000 D03 AD - SN: 495**

Calibration procedure(s) **QA CAL-06.v22  
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **April 28, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	28-Sep-10 (No:10376)	Sep-11
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	07-Jun-10 (in house check)	In house check: Jun-11

Calibrated by: **Name: Dominique Steffen, Function: Technician, Signature: [Handwritten Signature]**

Approved by: **Fin Bornholt, R&D Director, Signature: [Handwritten Signature]**

Issued: April 28, 2011

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Accreditation No.: **SCS 108**

## Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

## Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
  - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
  - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
  - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
  - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
  - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
  - *Power consumption:* Typical value for information. Supply currents in various operating modes.

## DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 $\mu$ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.324 $\pm$ 0.1% (k=2)	405.291 $\pm$ 0.1% (k=2)	405.622 $\pm$ 0.1% (k=2)
Low Range	3.95043 $\pm$ 0.7% (k=2)	3.97613 $\pm$ 0.7% (k=2)	3.95159 $\pm$ 0.7% (k=2)

## Connector Angle

Connector Angle to be used in DASY system	227.5 $^{\circ}$ $\pm$ 1 $^{\circ}$
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## Appendix

### 1. DC Voltage Linearity

High Range		Reading ( $\mu\text{V}$ )	Difference ( $\mu\text{V}$ )	Error (%)
Channel X	+ Input	199993.1	-2.74	-0.00
Channel X	+ Input	20001.66	1.46	0.01
Channel X	- Input	-19994.94	5.16	-0.03
Channel Y	+ Input	200006.0	1.16	0.00
Channel Y	+ Input	20002.16	1.86	0.01
Channel Y	- Input	-19997.98	2.02	-0.01
Channel Z	+ Input	200005.6	1.57	0.00
Channel Z	+ Input	20003.05	3.05	0.02
Channel Z	- Input	-19998.31	1.59	-0.01

Low Range		Reading ( $\mu\text{V}$ )	Difference ( $\mu\text{V}$ )	Error (%)
Channel X	+ Input	2000.3	0.26	0.01
Channel X	+ Input	199.66	-0.24	-0.12
Channel X	- Input	-200.28	-0.38	0.19
Channel Y	+ Input	2001.0	1.06	0.05
Channel Y	+ Input	200.75	0.85	0.42
Channel Y	- Input	-202.12	-2.12	1.06
Channel Z	+ Input	1999.0	-1.13	-0.06
Channel Z	+ Input	198.35	-1.65	-0.82
Channel Z	- Input	-200.94	-1.04	0.52

### 2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading ( $\mu\text{V}$ )	Low Range Average Reading ( $\mu\text{V}$ )
Channel X	200	2.91	1.12
	- 200	0.15	-1.40
Channel Y	200	-0.69	-0.74
	- 200	-0.12	-0.47
Channel Z	200	2.83	2.71
	- 200	-4.22	-4.44

### 3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X ( $\mu\text{V}$ )	Channel Y ( $\mu\text{V}$ )	Channel Z ( $\mu\text{V}$ )
Channel X	200	-	2.33	0.36
Channel Y	200	2.17	-	4.08
Channel Z	200	3.22	-0.54	-

#### 4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15791	16416
Channel Y	15742	16582
Channel Z	15883	16533

#### 5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M $\Omega$

	Average ( $\mu$ V)	min. Offset ( $\mu$ V)	max. Offset ( $\mu$ V)	Std. Deviation ( $\mu$ V)
Channel X	-1.87	-3.03	-0.77	0.45
Channel Y	-1.74	-2.98	-0.06	0.56
Channel Z	-1.44	-2.79	-0.14	0.61

#### 6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

#### 7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

#### 8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

#### 9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: DAE3-577\_Jan11

CALIBRATION CERTIFICATE

Object: DAE3 - SD 000 D03 AA - SN: 577
Calibration procedure(s): QA CAL-06.v22 Calibration procedure for the data acquisition electronics (DAE)
Calibration date: January 13, 2011

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Table with 4 columns: Standards, ID #, Date, and Calibration/Check status. Includes Primary Standards (Keithley Multimeter) and Secondary Standards (Calibrator Box).

Calibrated by: Andrea Guntli, Technician
Approved by: Fin Bomholt, R&D Director

Issued: January 13, 2011

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Zaughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

### Glossary

DAE data acquisition electronics  
Connector angle information used in DAS Y system to align probe sensor X to the robot coordinate system.

### Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement*: Calibration Factor assessed for use in DAS Y system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
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  - *DC Voltage Measurement Linearity*: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
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  - *AD Converter Values with inputs shorted*: Values on the internal AD converter corresponding to zero input voltage
  - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
  - *Input Offset Current*: Typical value for information; Maximum channel input offset current, not considering the input resistance.
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  - *Power consumption*: Typical value for information. Supply currents in various operating modes.



**DC Voltage Measurement**

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1µV , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.389 ± 0.1% (k=2)	403.857 ± 0.1% (k=2)	404.295 ± 0.1% (k=2)
Low Range	3.93277 ± 0.7% (k=2)	3.93544 ± 0.7% (k=2)	3.95803 ± 0.7% (k=2)

**Connector Angle**

Connector Angle to be used in DASY system	102.0 ° ± 1 °
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**Appendix**

**1. DC Voltage Linearity**

High Range	Heading (µV)	Difference (µV)	Error (%)
Channel X + Input	200005.8	1.57	0.00
Channel X + Input	20004.13	3.33	0.02
Channel X - Input	-19995.53	4.67	-0.02
Channel Y + Input	200003.4	0.31	0.00
Channel Y + Input	19999.89	0.09	0.00
Channel Y - Input	-20000.18	-0.28	0.00
Channel Z + Input	200002.7	0.22	0.00
Channel Z + Input	19999.37	-0.63	-0.00
Channel Z - Input	-19999.27	0.43	-0.00

Low Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	2000.0	-0.14	-0.01
Channel X + Input	199.95	-0.05	-0.03
Channel X - Input	-200.10	-0.10	0.05
Channel Y + Input	2000.0	-0.12	-0.01
Channel Y + Input	199.43	-0.57	-0.29
Channel Y - Input	-201.05	-1.25	0.63
Channel Z + Input	1999.5	-0.28	-0.01
Channel Z + Input	198.64	-1.56	-0.78
Channel Z - Input	-200.91	-0.81	0.40

**2. Common mode sensitivity**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (µV)	Low Range Average Reading (µV)
Channel X	200	14.61	12.98
	- 200	-11.87	-13.38
Channel Y	200	-6.98	-7.04
	- 200	5.39	5.42
Channel Z	200	-1.74	-1.94
	- 200	0.61	0.35

**3. Channel separation**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	3.35	0.10
Channel Y	200	2.66	-	2.41
Channel Z	200	2.57	0.13	-



**4. AD-Converter Values with inputs shorted**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15969	16221
Channel Y	15855	15246
Channel Z	16222	17974

**5. Input Offset Measurement**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-1.07	-4.93	0.31	0.67
Channel Y	-0.69	-1.59	0.48	0.40
Channel Z	-1.47	-2.56	-0.81	0.32

**6. Input Offset Current**

Nominal input circuitry offset current on all channels: <25fA

**7. Input Resistance** (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

**8. Low Battery Alarm Voltage** (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

**9. Power Consumption** (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: DAE4-778\_Oct10

CALIBRATION CERTIFICATE

Object: DAE4 - SD 000 D04 BJ - SN: 778
Calibration procedure(s): QA CAL-06.v22 Calibration procedure for the data acquisition electronics (DAE)
Calibration date: October 22, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Standards, ID #, Date, and Check/Calibration status. Includes Primary Standards (Keithley Multimeter) and Secondary Standards (Calibrator Box).

Calibrated by: Eric Hainfeld, Technician
Approved by: Fin Bornholt, R&D Director

Issued: October 22, 2010

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Zeughausstrasse 43, 8004 Zurich, Switzerland



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**S** Swiss Calibration Service

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Accreditation No.: **SCS 108**

## Glossary

**DAE** data acquisition electronics  
**Connector angle** information used in DAS Y system to align probe sensor X to the robot coordinate system.

## Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DAS Y system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
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  - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
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  - **Power consumption:** Typical value for information. Supply currents in various operating modes.



**DC Voltage Measurement**

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1µV , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.679 ± 0.1% (k=2)	403.480 ± 0.1% (k=2)	405.025 ± 0.1% (k=2)
Low Range	3.98633 ± 0.7% (k=2)	3.96375 ± 0.7% (k=2)	3.99940 ± 0.7% (k=2)

**Connector Angle**

Connector Angle to be used in DASY system	64.5 ° ± 1 °
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**Appendix**

**1. DC Voltage Linearity**

High Range	Reading ( $\mu\text{V}$ )	Difference ( $\mu\text{V}$ )	Error (%)
Channel X + Input	200004.4	1.89	0.00
Channel X + Input	20001.11	1.41	0.01
Channel X - Input	-19998.36	1.54	-0.01
Channel Y + Input	199996.1	3.42	0.00
Channel Y + Input	19999.75	0.35	0.00
Channel Y - Input	-19999.92	-0.12	0.00
Channel Z + Input	200002.7	1.29	0.00
Channel Z + Input	19996.85	-2.55	-0.01
Channel Z - Input	-20004.31	-4.61	0.02

Low Range	Reading ( $\mu\text{V}$ )	Difference ( $\mu\text{V}$ )	Error (%)
Channel X + Input	2000.0	0.09	0.00
Channel X + Input	200.02	0.02	0.01
Channel X - Input	-198.62	1.48	-0.74
Channel Y + Input	1999.6	-0.58	-0.03
Channel Y + Input	199.13	-0.57	-0.29
Channel Y - Input	-200.71	-0.61	0.31
Channel Z + Input	2000.1	-0.01	-0.00
Channel Z + Input	198.96	-1.14	-0.57
Channel Z - Input	-200.98	-0.98	0.49

**2. Common mode sensitivity**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading ( $\mu\text{V}$ )	Low Range Average Reading ( $\mu\text{V}$ )
Channel X	200	-5.28	-6.07
	- 200	6.79	6.12
Channel Y	200	-1.80	-1.60
	- 200	0.97	0.35
Channel Z	200	-9.76	-9.86
	- 200	7.56	7.61

**3. Channel separation**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X ( $\mu\text{V}$ )	Channel Y ( $\mu\text{V}$ )	Channel Z ( $\mu\text{V}$ )
Channel X	200	-	1.86	-0.66
Channel Y	200	2.28	-	2.89
Channel Z	200	1.68	-0.15	-



**4. AD-Converter Values with inputs shorted**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16056	16950
Channel Y	16153	13741
Channel Z	16441	16086

**5. Input Offset Measurement**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.32	-2.35	2.08	0.55
Channel Y	-1.83	-2.96	-0.72	0.47
Channel Z	-1.93	-3.00	-0.90	0.45

**6. Input Offset Current**

Nominal Input circuitry offset current on all channels: <25fA

**7. Input Resistance** (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

**8. Low Battery Alarm Voltage** (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

**9. Power Consumption** (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: **SCS 108**

Client: **Fujitsu Research Institute (Aachen)**

Certificate No: **DAE4-1249\_Feb11**

## CALIBRATION CERTIFICATE

Object: **DAE4 - SD 000 D04 BJ - SN: 1249**

Calibration procedure(s): **QA CAL-06.v22  
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **February 21, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature ( $22 \pm 3$ )°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	28-Sep-10 (No:10376)	Sep-11
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	07-Jun-10 (in house check)	In house check: Jun-11

Calibrated by: **Dominique Steffen** (Name), **Technician** (Function),  (Signature)

Approved by: **Fin Bomhoff** (Name), **R&D Director** (Function),  (Signature)

Issued: February 23, 2011

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## Glossary

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## DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 $\mu$ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.884 $\pm$ 0.1% (k=2)	403.606 $\pm$ 0.1% (k=2)	404.329 $\pm$ 0.1% (k=2)
Low Range	3.95010 $\pm$ 0.7% (k=2)	3.97181 $\pm$ 0.7% (k=2)	3.99227 $\pm$ 0.7% (k=2)

## Connector Angle

Connector Angle to be used in DASY system	264.5 $^{\circ}$ $\pm$ 1 $^{\circ}$
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## Appendix

### 1. DC Voltage Linearity

High Range		Reading ( $\mu\text{V}$ )	Difference ( $\mu\text{V}$ )	Error (%)
Channel X	+ Input	200003.1	-0.44	-0.00
Channel X	+ Input	19999.46	-0.74	-0.00
Channel X	- Input	-19998.91	1.59	-0.01
Channel Y	+ Input	200003.6	1.31	0.00
Channel Y	+ Input	19999.42	-0.78	-0.00
Channel Y	- Input	-20001.30	-1.80	0.01
Channel Z	+ Input	200013.4	12.01	0.01
Channel Z	+ Input	20000.65	0.65	0.00
Channel Z	- Input	-20000.97	-1.47	0.01

Low Range		Reading ( $\mu\text{V}$ )	Difference ( $\mu\text{V}$ )	Error (%)
Channel X	+ Input	2001.3	1.22	0.06
Channel X	+ Input	199.82	-0.08	-0.04
Channel X	- Input	-200.39	-0.39	0.20
Channel Y	+ Input	1999.2	-0.95	-0.05
Channel Y	+ Input	199.20	-0.70	-0.35
Channel Y	- Input	-201.25	-1.35	0.67
Channel Z	+ Input	2001.0	0.98	0.05
Channel Z	+ Input	198.82	-0.98	-0.49
Channel Z	- Input	-201.67	-1.67	0.84

### 2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading ( $\mu\text{V}$ )	Low Range Average Reading ( $\mu\text{V}$ )
Channel X	200	-2.81	-4.67
	- 200	6.20	4.41
Channel Y	200	5.96	5.63
	- 200	-7.15	-7.01
Channel Z	200	-24.87	-24.52
	- 200	27.23	27.09

### 3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X ( $\mu\text{V}$ )	Channel Y ( $\mu\text{V}$ )	Channel Z ( $\mu\text{V}$ )
Channel X	200	-	3.80	0.28
Channel Y	200	2.77	-	4.40
Channel Z	200	1.74	-1.02	-

#### 4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16365	16336
Channel Y	15884	16495
Channel Z	16086	16313

#### 5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M $\Omega$

	Average ( $\mu$ V)	min. Offset ( $\mu$ V)	max. Offset ( $\mu$ V)	Std. Deviation ( $\mu$ V)
Channel X	0.25	-1.50	1.93	0.63
Channel Y	-0.72	-1.94	0.63	0.43
Channel Z	-0.87	-2.04	0.55	0.50

#### 6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

#### 7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

#### 8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

#### 9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: SCS 108

Client Auden

Certificate No: ES3-3071\_Jun10

CALIBRATION CERTIFICATE

Object ES3DV3 - SN:3071
Calibration procedure(s) QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2 Calibration procedure for dosimetric E-field probes
Calibration date: June 22, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Certificate No.), Scheduled Calibration. Lists equipment like Power meter E4419B, Power sensor E4412A, Reference 3 dB Attenuator, etc.

Table with 4 columns: Secondary Standards, ID #, Check Date (in house), Scheduled Check. Lists RF generator HP 8648C, Network Analyzer HP 8753E.

Calibrated by: Jeton Kastrali, Laboratory Technician
Approved by: Katja Pokovic, Technical Manager

Signature (handwritten signatures)

Issued: June 22, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



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Accreditation No.: SCS 108

Glossary:

Table with 2 columns: Term and Definition. Terms include TSL, NORMx,y,z, ConvF, DCP, CF, A, B, C, Polarization phi, and Polarization theta.

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization theta = 0 (f <= 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E^2-field uncertainty inside TSL (see below ConvF).
NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DAS Y4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f <= 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DAS Y4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DAS Y version 4.4 and higher which allows extending the validity from +/- 50 MHz to +/- 100 MHz.
Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ES3DV3 SN:3071

June 22, 2010

# Probe ES3DV3

## SN:3071

Manufactured:	December 14, 2004
Last calibrated:	June 22, 2009
Recalibrated:	June 22, 2010

Calibrated for DASYS/EASY Systems

(Note: non-compatible with DASYS2 system!)



ES3DV3 SN:3071

June 22, 2010

**DASY/EASY - Parameters of Probe: ES3DV3 SN:3071**

**Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ( $\mu\text{V}/(\text{V}/\text{m})^2$ ) <sup>A</sup>	1.24	1.22	0.97	$\pm 10.1\%$
DCP (mV) <sup>B</sup>	96.6	92.2	92.6	

**Modulation Calibration Parameters**

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc <sup>E</sup> (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	300.0	$\pm 1.5\%$
			Y	0.00	0.00	1.00	300.0	
			Z	0.00	0.00	1.00	300.0	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor  $k=2$ , which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the  $E^2$ -field uncertainty inside TSL (see Pages 5 and 6).

<sup>B</sup> Numerical linearization parameter: uncertainty not required.

<sup>E</sup> Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



ES3DV3 SN:3071

June 22, 2010

## DASY/EASY - Parameters of Probe: ES3DV3 SN:3071

### Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] <sup>c</sup>	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	41.5 ± 5%	0.90 ± 5%	5.81	5.81	5.81	0.98	1.02 ± 11.0%
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	5.67	5.67	5.67	0.75	1.15 ± 11.0%
1750	± 50 / ± 100	40.1 ± 5%	1.37 ± 5%	4.94	4.94	4.94	0.35	1.77 ± 11.0%
1900	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	4.73	4.73	4.73	0.57	1.35 ± 11.0%
2000	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	4.67	4.67	4.67	0.56	1.35 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	4.20	4.20	4.20	0.38	1.93 ± 11.0%

<sup>c</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



ES3DV3 SN:3071

June 22, 2010

## DASY/EASY - Parameters of Probe: ES3DV3 SN:3071

### Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] <sup>c</sup>	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	55.2 ± 5%	0.97 ± 5%	5.79	5.79	5.79	0.73	1.17 ± 11.0%
900	± 50 / ± 100	55.0 ± 5%	1.05 ± 5%	5.71	5.71	5.71	0.85	1.14 ± 11.0%
1750	± 50 / ± 100	53.4 ± 5%	1.49 ± 5%	4.52	4.52	4.52	0.40	1.79 ± 11.0%
1900	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.30	4.30	4.30	0.38	2.04 ± 11.0%
2000	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.36	4.36	4.36	0.42	1.91 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	4.00	4.00	4.00	0.80	1.25 ± 11.0%

<sup>c</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

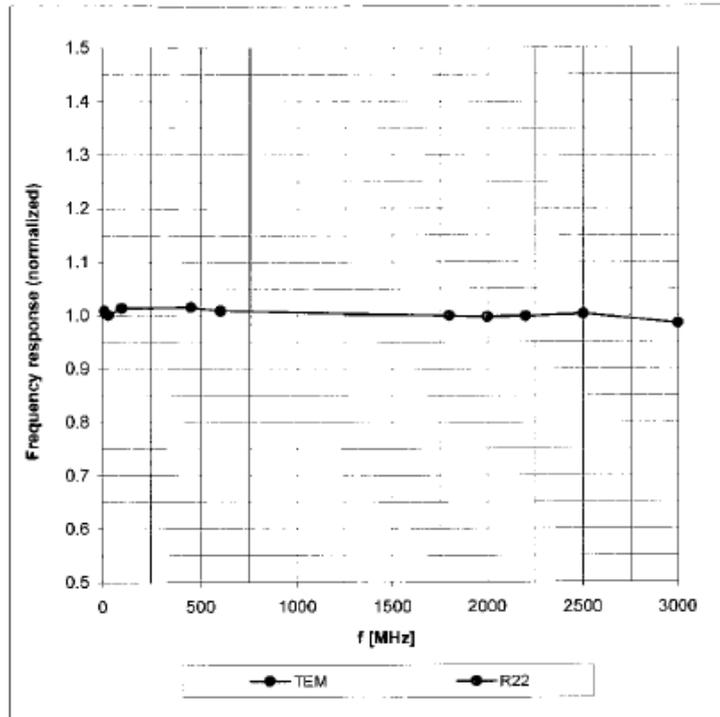


ES3DV3 SN:3071

June 22, 2010

### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



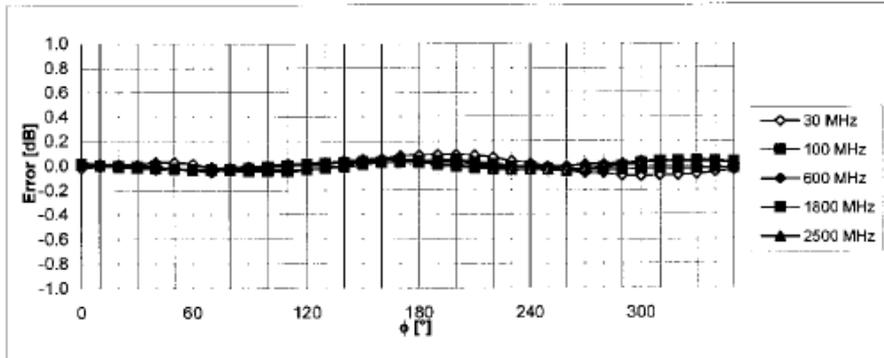
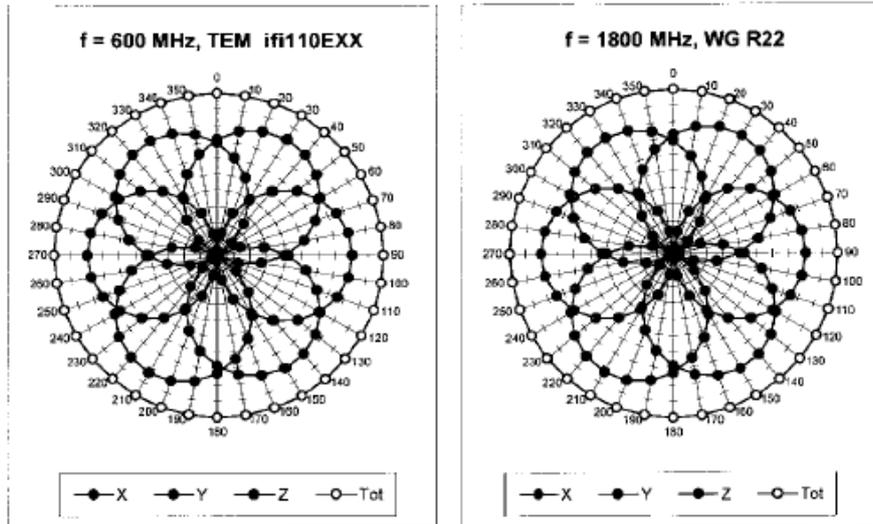
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  ( $k=2$ )



ES3DV3 SN:3071

June 22, 2010

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



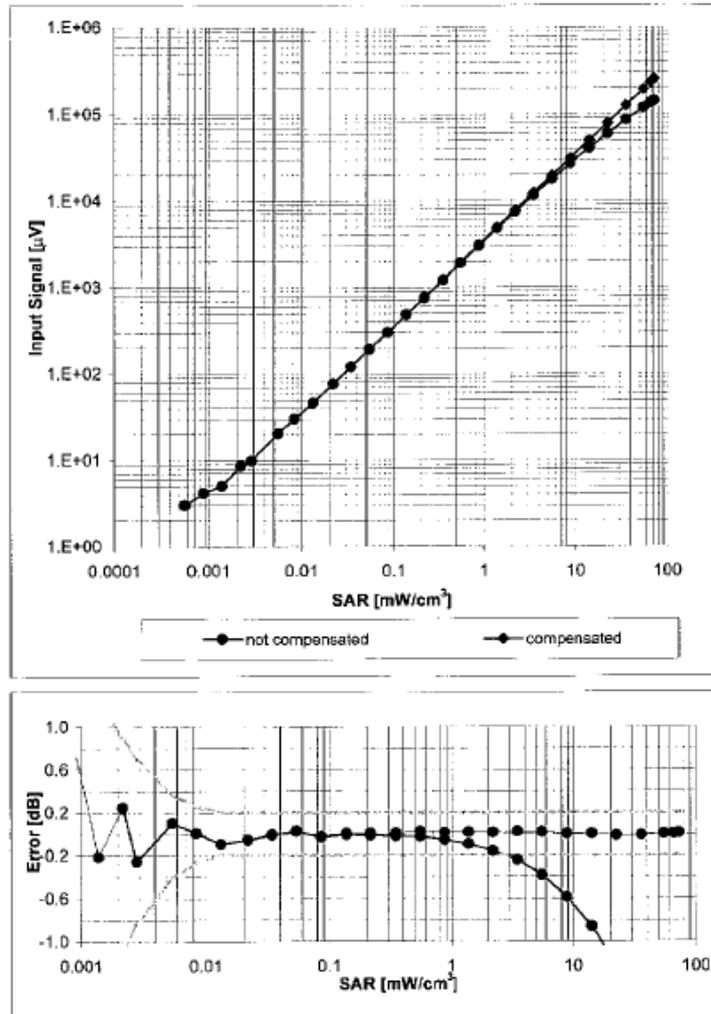
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  (k=2)



ES3DV3 SN:3071

June 22, 2010

### Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22, $f = 1800 \text{ MHz}$ )



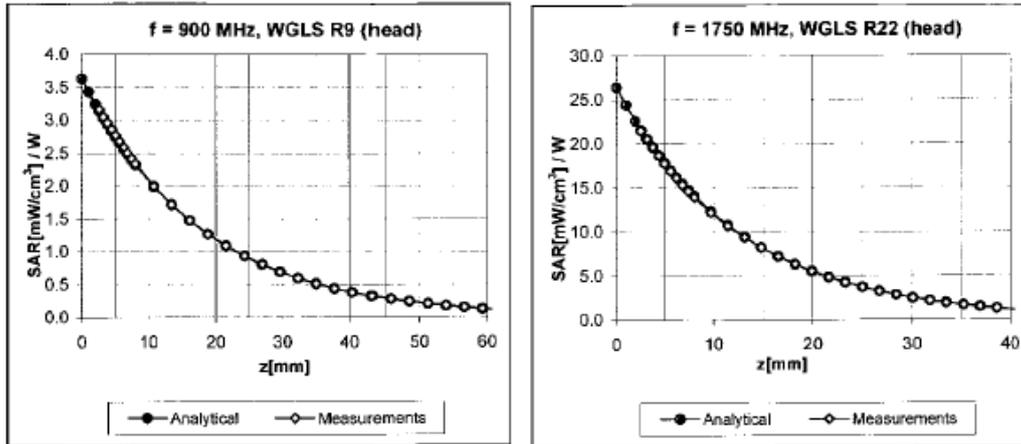
Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )



ES3DV3 SN:3071

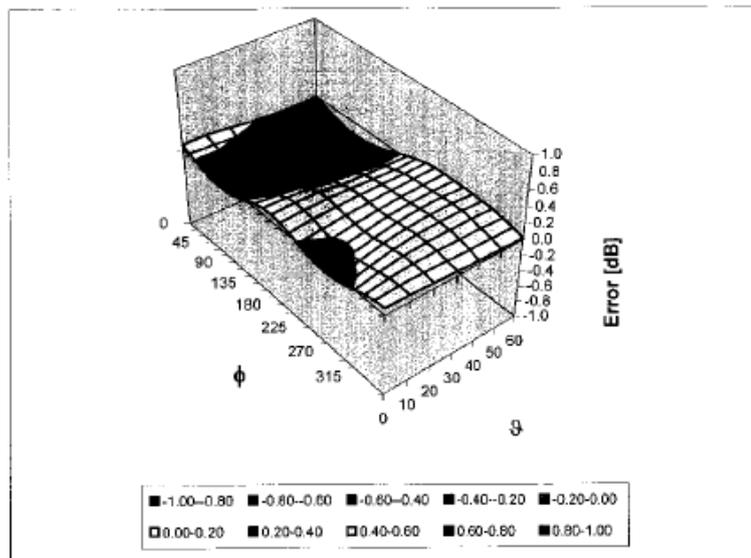
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### Conversion Factor Assessment



### Deviation from Isotropy in HSL

Error ( $\phi, \theta$ ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  (k=2)



ES3DV3 SN:3071

June 22, 2010

**Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	4.0 mm
Probe Tip to Sensor X Calibration Point	2 mm
Probe Tip to Sensor Y Calibration Point	2 mm
Probe Tip to Sensor Z Calibration Point	2 mm
Recommended Measurement Distance from Surface	3 mm



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: ET3-1787\_May10

CALIBRATION CERTIFICATE

Object: ET3DV6 - SN:1787
Calibration procedure(s): QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2
Calibration date: May 18, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Certificate No.), Scheduled Calibration. Lists equipment like Power meter E4419B, Power sensor E4412A, Reference 3 dB Attenuator, etc.

Table with 4 columns: Secondary Standards, ID #, Check Date (in house), Scheduled Check. Lists RF generator HP 8648C, Network Analyzer HP 8753E.

Calibrated by: Jeton Kastrali, Laboratory Technician
Approved by: Katja Pokovic, Technical Manager

Handwritten signatures of Jeton Kastrali and Katja Pokovic.

Issued: May 22, 2010

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Accreditation No.: **SCS 108**

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## Glossary:

TSL	tissue simulating liquid
NORM <sub>x,y,z</sub>	sensitivity in free space
ConvF	sensitivity in TSL / NORM <sub>x,y,z</sub>
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization $\varphi$	$\varphi$ rotation around probe axis
Polarization $\vartheta$	$\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

## Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

## Methods Applied and Interpretation of Parameters:

- NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). NORM<sub>x,y,z</sub> are only intermediate values, i.e., the uncertainties of NORM<sub>x,y,z</sub> does not effect the E<sup>2</sup>-field uncertainty inside TSL (see below ConvF).
- NORM(f)<sub>x,y,z</sub>** = NORM<sub>x,y,z</sub> \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DAS Y4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP<sub>x,y,z</sub>**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A<sub>x,y,z</sub>; B<sub>x,y,z</sub>; C<sub>x,y,z</sub>; VR<sub>x,y,z</sub>; A, B, C** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DAS Y4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM<sub>x,y,z</sub> \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DAS Y version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ET3DV6 SN:1787

May 18, 2010

# Probe ET3DV6

## SN:1787

Manufactured:	May 28, 2003
Last calibrated:	May 26, 2009
Recalibrated:	May 18, 2010

Calibrated for DAS Y/EASY Systems

(Note: non-compatible with DAS Y2 system!)



ET3DV6 SN:1787

May 18, 2010

DASY/EASY - Parameters of Probe: ET3DV6 SN:1787

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ( $\mu\text{V}/(\text{V}/\text{m})^2$ ) <sup>A</sup>	1.60	1.79	2.10	$\pm 10.1\%$
DCP (mV) <sup>B</sup>	92.4	95.5	91.0	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc <sup>E</sup> (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	300.0	$\pm 1.5\%$
			Y	0.00	0.00	1.00	300.0	
			Z	0.00	0.00	1.00	300.0	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor  $k=2$ , which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the  $E^2$ -field uncertainty inside TSL (see Pages 5 and 6).

<sup>B</sup> Numerical linearization parameter: uncertainty not required.

<sup>E</sup> Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



ET3DV6 SN:1787

May 18, 2010

## DASY/EASY - Parameters of Probe: ET3DV6 SN:1787

### Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] <sup>□</sup>	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
750	± 50 / ± 100	41.5 ± 5%	0.90 ± 5%	6.56	6.56	6.56	0.52	1.96 ± 11.0%
835	± 50 / ± 100	41.9 ± 5%	0.89 ± 5%	6.21	6.21	6.21	0.42	2.23 ± 11.0%
1750	± 50 / ± 100	40.1 ± 5%	1.37 ± 5%	5.36	5.36	5.36	0.49	1.18 ± 11.0%
1900	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.09	5.09	5.09	0.66	2.20 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	4.50	4.50	4.50	0.99	1.63 ± 11.0%

<sup>□</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



ET3DV6 SN:1787

May 18, 2010

## DASY/EASY - Parameters of Probe: ET3DV6 SN:1787

### Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] <sup>c</sup>	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
750	± 50 / ± 100	55.5 ± 5%	0.96 ± 5%	6.22	6.22	6.22	0.48	2.20 ± 11.0%
835	± 50 / ± 100	55.2 ± 5%	0.97 ± 5%	6.12	6.12	6.12	0.39	2.45 ± 11.0%
1750	± 50 / ± 100	53.4 ± 5%	1.49 ± 5%	4.72	4.72	4.72	0.63	2.90 ± 11.0%
1900	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.47	4.47	4.47	0.88	2.39 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	4.03	4.03	4.03	0.99	1.35 ± 11.0%

<sup>c</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

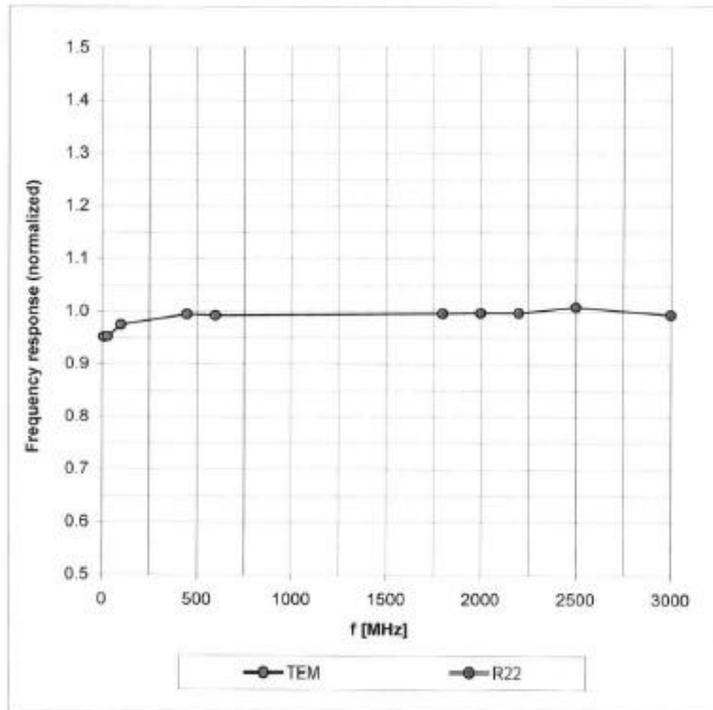


ET3DV6 SN:1787

May 18, 2010

### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



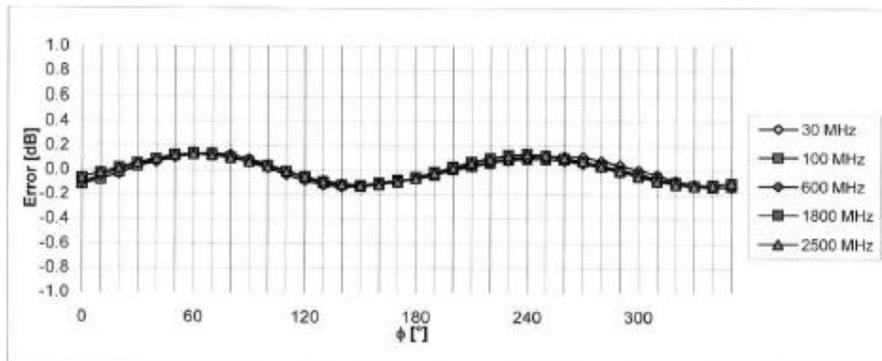
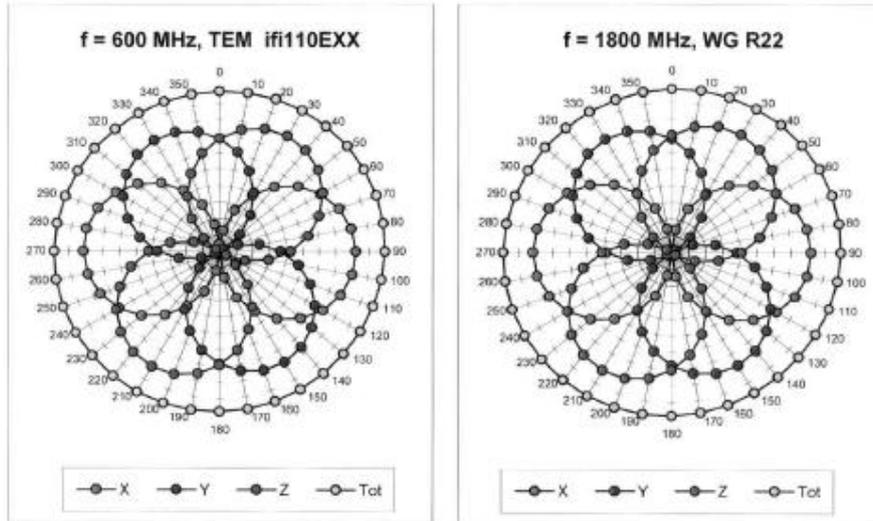
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)



ET3DV6 SN:1787

May 18, 2010

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$

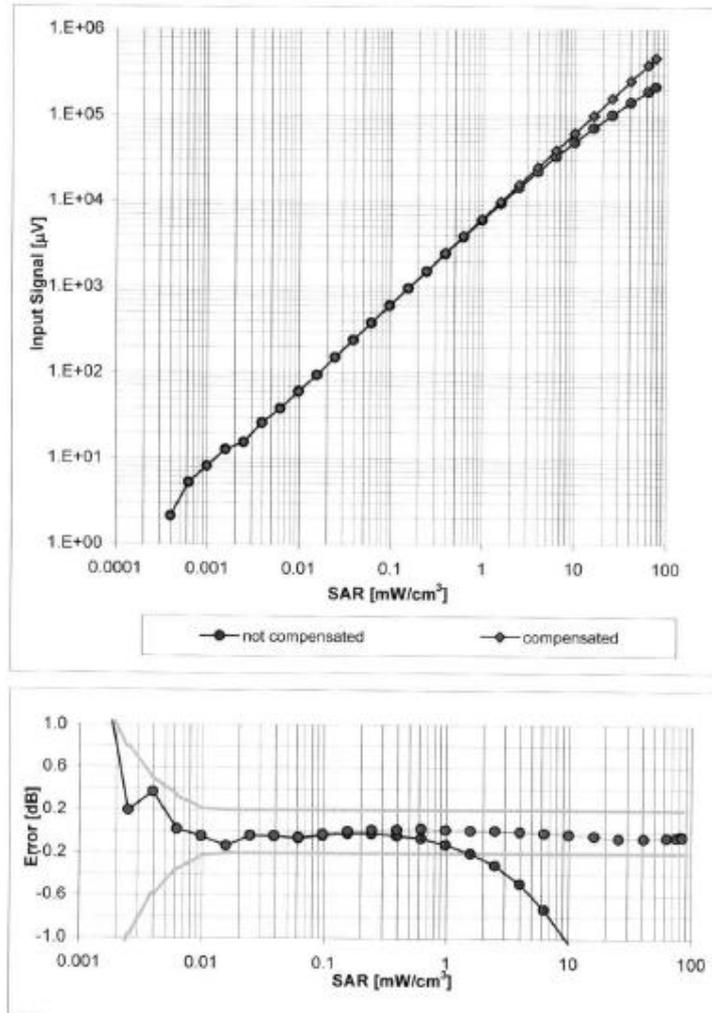


Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

ET3DV6 SN:1787

May 18, 2010

**Dynamic Range f(SAR<sub>head</sub>)**  
 (Waveguide R22, f = 1800 MHz)

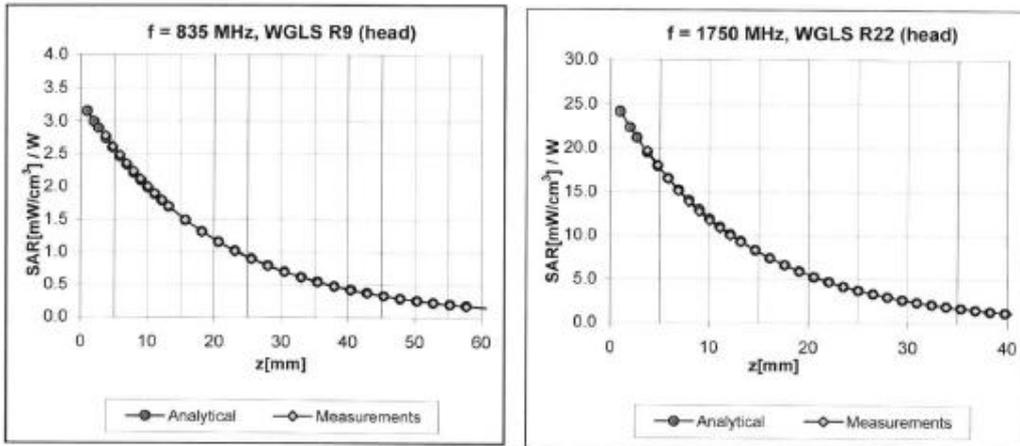


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

ET3DV6 SN:1787

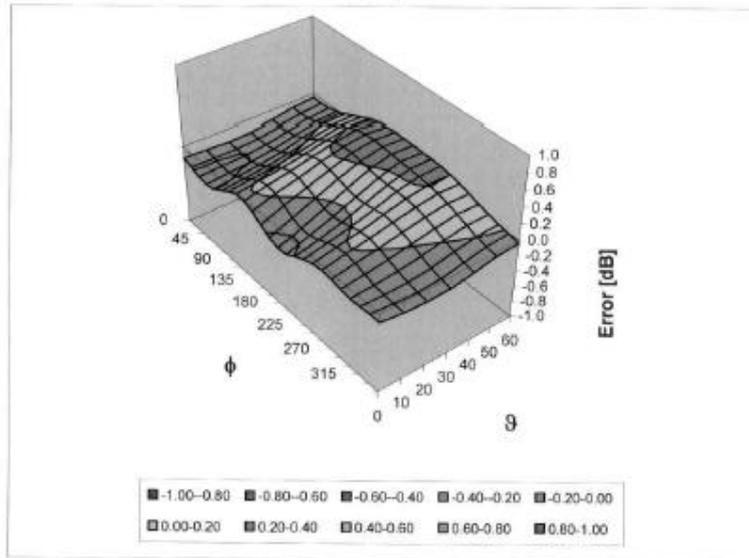
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### Conversion Factor Assessment



### Deviation from Isotropy in HSL

Error ( $\phi$ ,  $\theta$ ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  (k=2)



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### Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	6.8 mm
Probe Tip to Sensor X Calibration Point	2.7 mm
Probe Tip to Sensor Y Calibration Point	2.7 mm
Probe Tip to Sensor Z Calibration Point	2.7 mm
Recommended Measurement Distance from Surface	4 mm